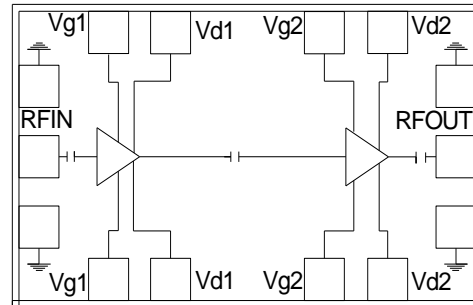


8.5 – 10 GHz 10 Watt Power Amplifier

Features

- ◆ Frequency Range : 8.5 – 10GHz
- ◆ 40.5 dBm Psat
- ◆ 14 dB Power gain
- ◆ 27% PAE
- ◆ High IP3
- ◆ Input Return Loss > 10 dB
- ◆ Output Return Loss > 9 dB
- ◆ Dual bias operation
- ◆ DC decoupled input and output
- ◆ 0.5 μ m InGaAs pHEMT Technology
- ◆ Chip dimension: 5.2 x 5.0 x 0.1 mm

Functional Diagram



Typical Applications

- ◆ RADAR
- ◆ Military & space
- ◆ LMDS, VSAT

Description

The ASL4015 is a X-band Power amplifier with 40.5dBm saturated output power. The PA uses 2 stages of amplification and operates in 8.5 – 10 GHz frequency range. The PA features 14dB of gain with input and output return losses of 10 dB and 9 dB respectively. The PA has a high IP3 of 47dBm and 27% PAE. This feature enables it to be used in the applications requiring efficiency along with linearity. The chip operates with dual bias supply voltage. The die is fabricated using a reliable 0.5 μ m InGaAs pHEMT technology. The Circuit grounds are provided through vias to the backside metallization.

Absolute Maximum Ratings ⁽¹⁾

Parameter	Absolute Maximum	Units
Drain bias voltage (Vd)	+10	volts
Drain current (Id)	5	A
RF input power (RFin at Vd=9V)	33	dBm
Operating temperature	-50 to +85	°C
Storage Temperature	-65 to +150	°C

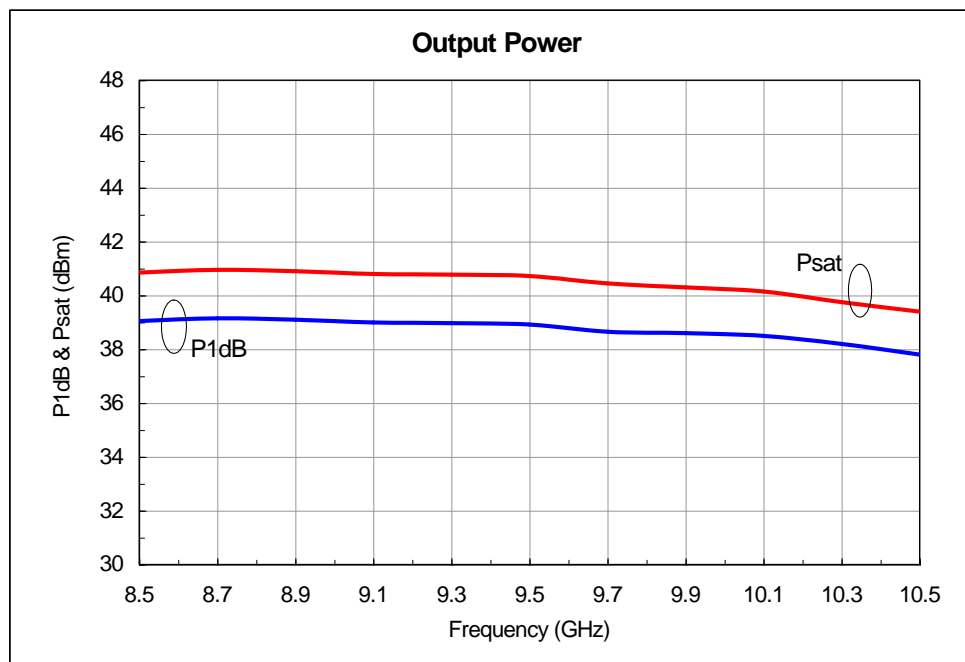
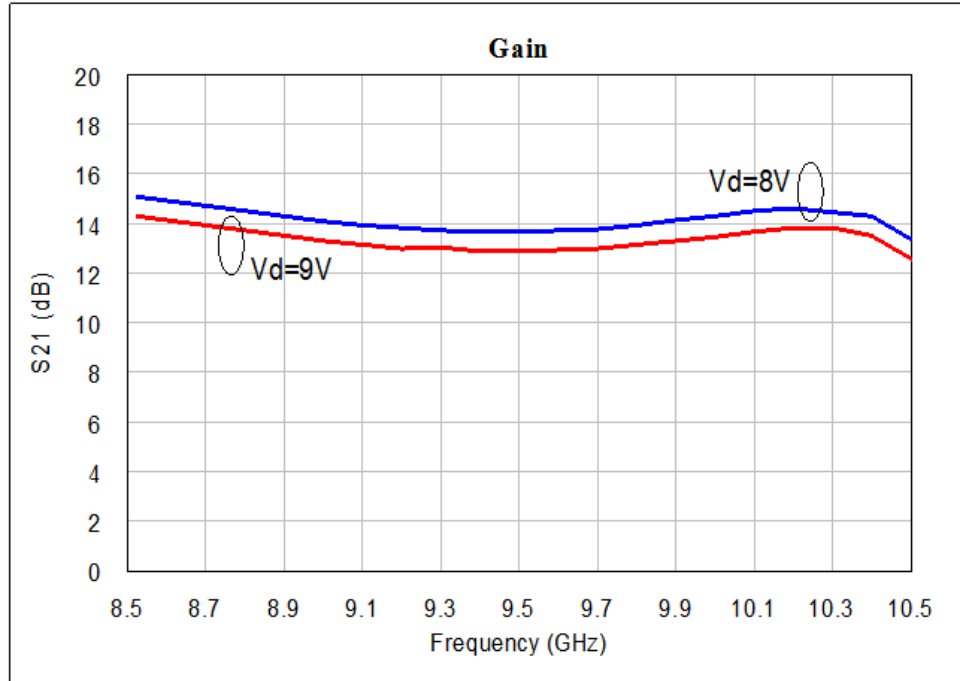
1. Operation beyond these limits may cause permanent damage to the component

Electrical Specifications ⁽¹⁾ @ T_A = 25 °C, V_{d1} = V_{d2} = 8V, V_{g1} = V_{g2} = -1.1V
Z_o = 50 Ω

Parameter	Typ.	Units
Frequency Range	8.5 – 10	GHz
Gain	14	dB
Gain Flatness	+/-0.5	dB
Output Power (P1 dB)	38.4	dBm
Input Return Loss	10	dB
Output Return Loss	9	dB
Saturated output power (P _{sat})	40.5	dBm
Output Third Order Intercept (IP3)	47	dBm
Power Added Efficiency (PAE)	27%	--
Supply Current(I _{dq})	2.9	A
Supply Current(I _{dsat} ²)	4.3	A

Note:

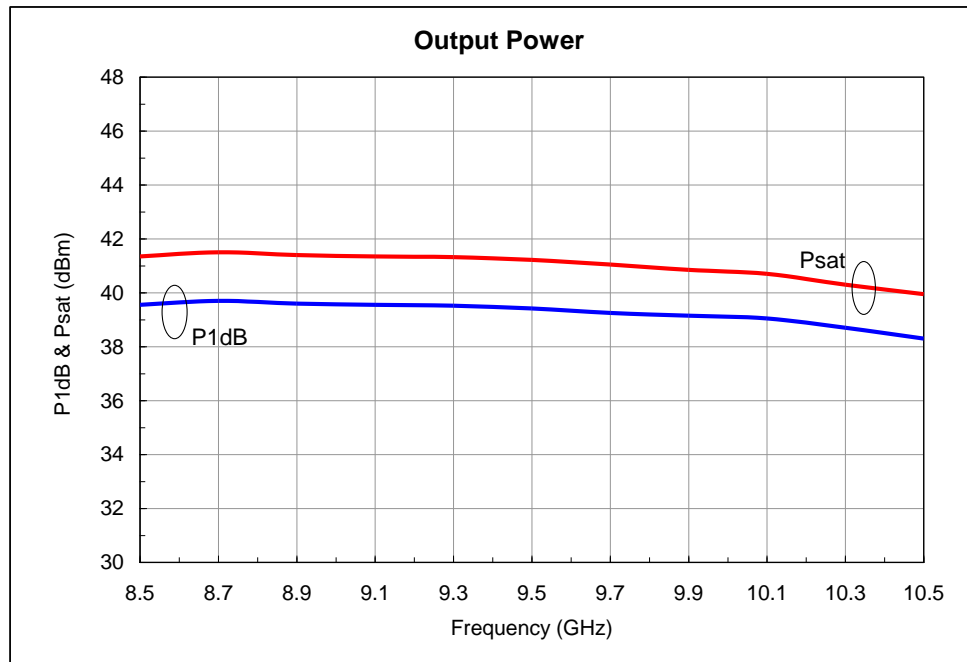
1. Electrical specifications as measured in test fixture.
2. I_{dsat} is the drain current corresponding to saturated output power.

Test fixture data
 $V_{d1} = V_{d2} = V_d$, $V_{g1} = V_{g2} = -1.1V$, Total Current (I_{dq}) = 2.9A, $T_A = 25\text{ }^\circ\text{C}$, Continuous DC Mode


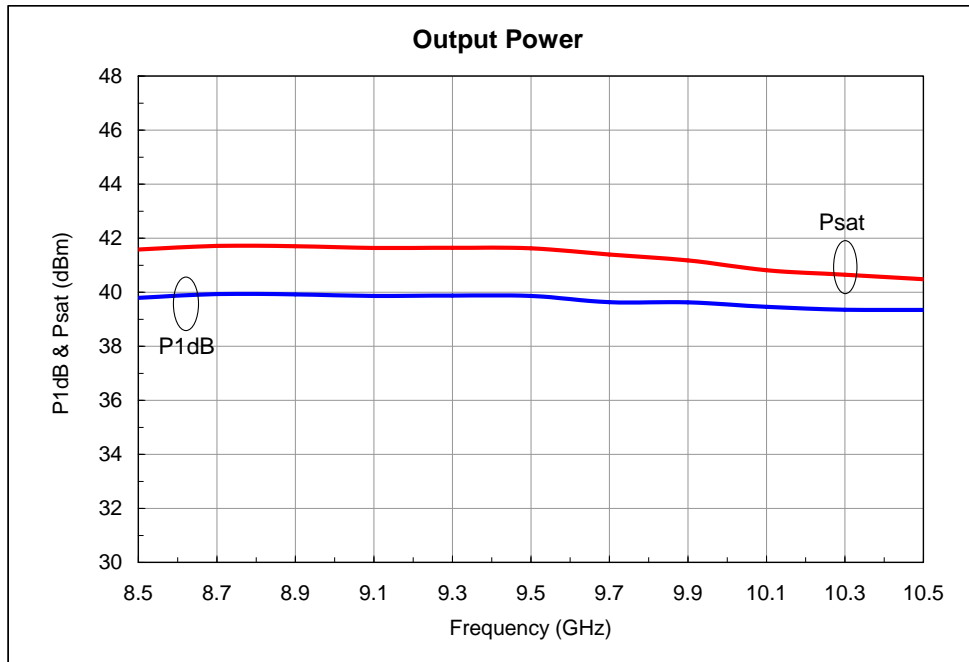
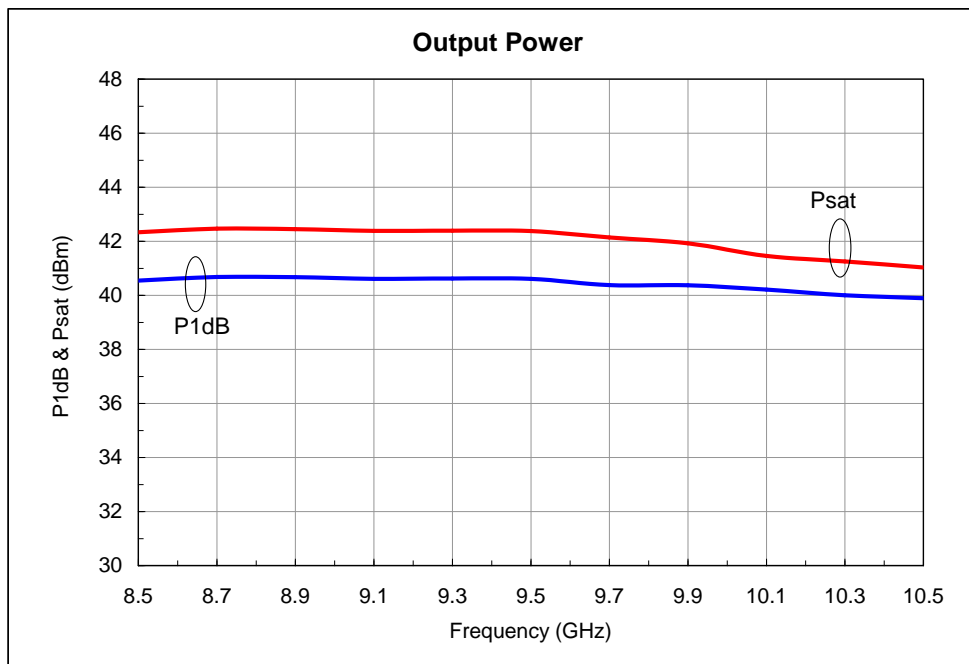
Output power @ Vd = 8V

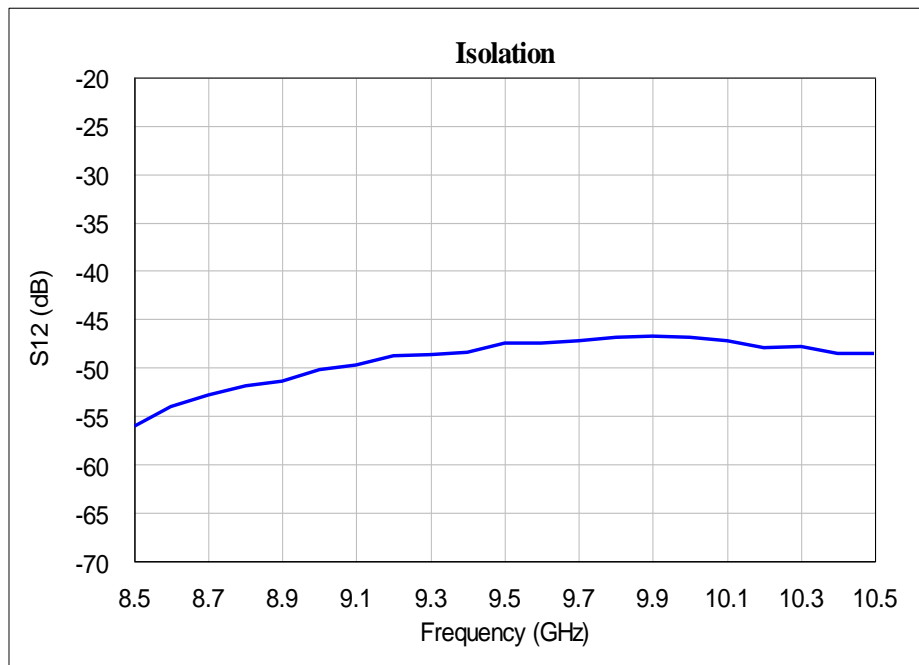
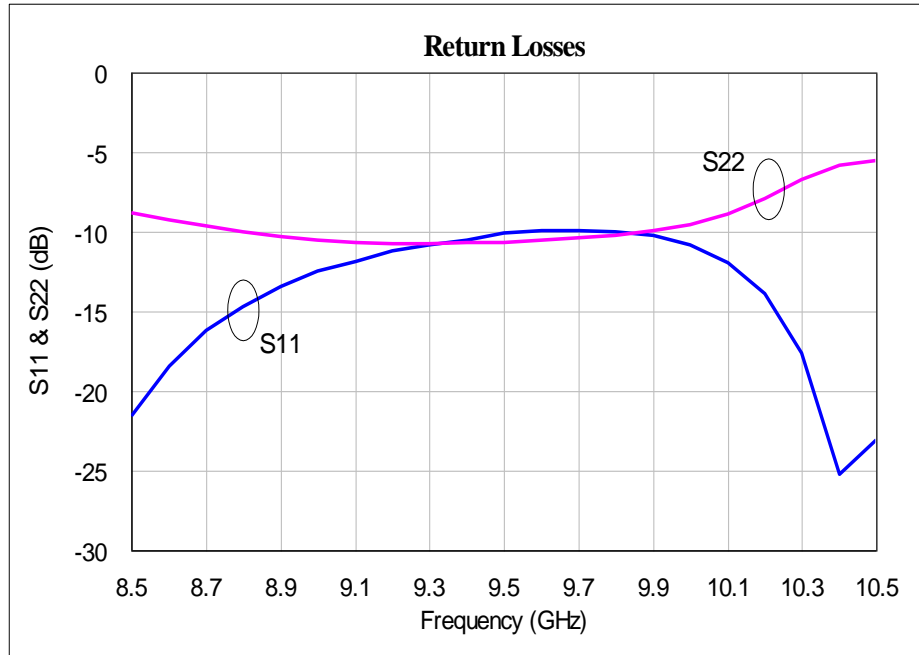
Test fixture data

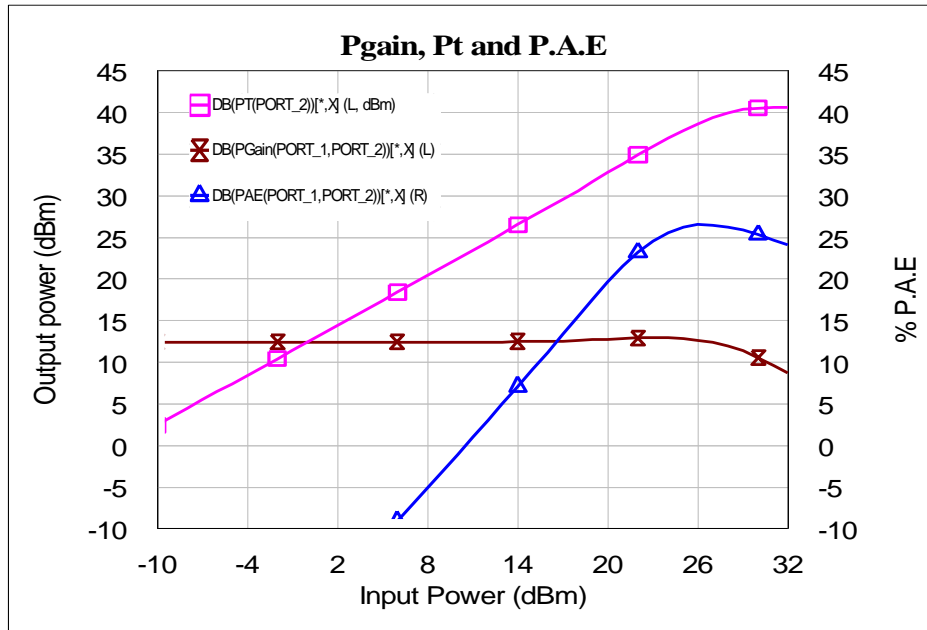
$V_{d1} = V_{d2} = V_d$, $V_{g1} = V_{g2} = -1.1V$, Total Current (I_{dq}) = 2.9A, $T_A = 25^\circ C$, Continuous DC Mode



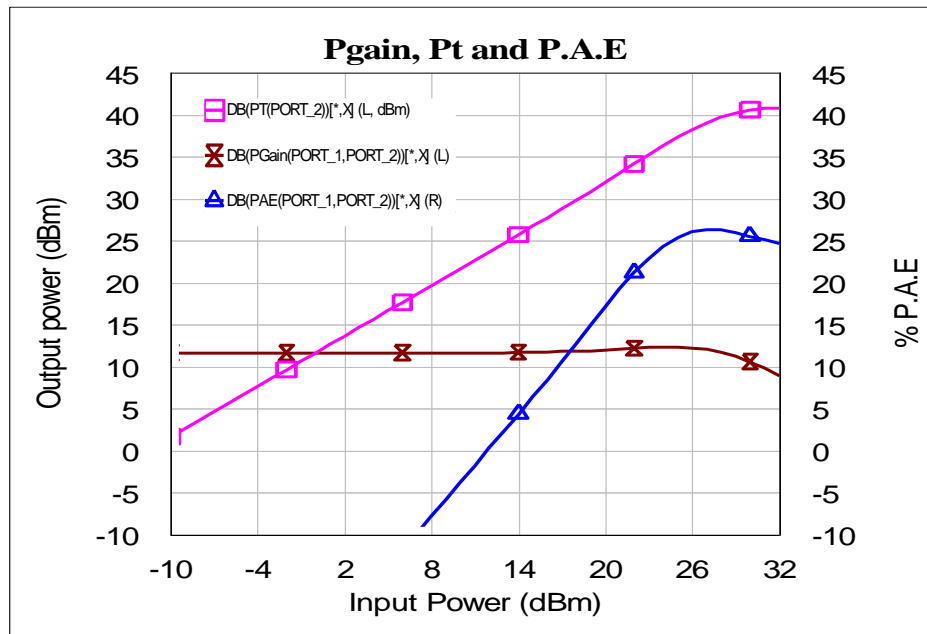
Output power @ $V_d = 9V$

Test fixture data
 $V_{d1}=V_{d2}=V_d$, $V_{g1}=V_{g2}=-1.1V$, Total Current ($I_{dq}=2.9A$, $I_{dsat}=4.3A$); $T_A=25^\circ C$, DC Pulsed Mode

 Output power at $V_d = 8V$; Gate Pulsed @ 10% Duty Cycle

 Output power at $V_d = 9V$; Gate Pulsed @ 10% Duty Cycle

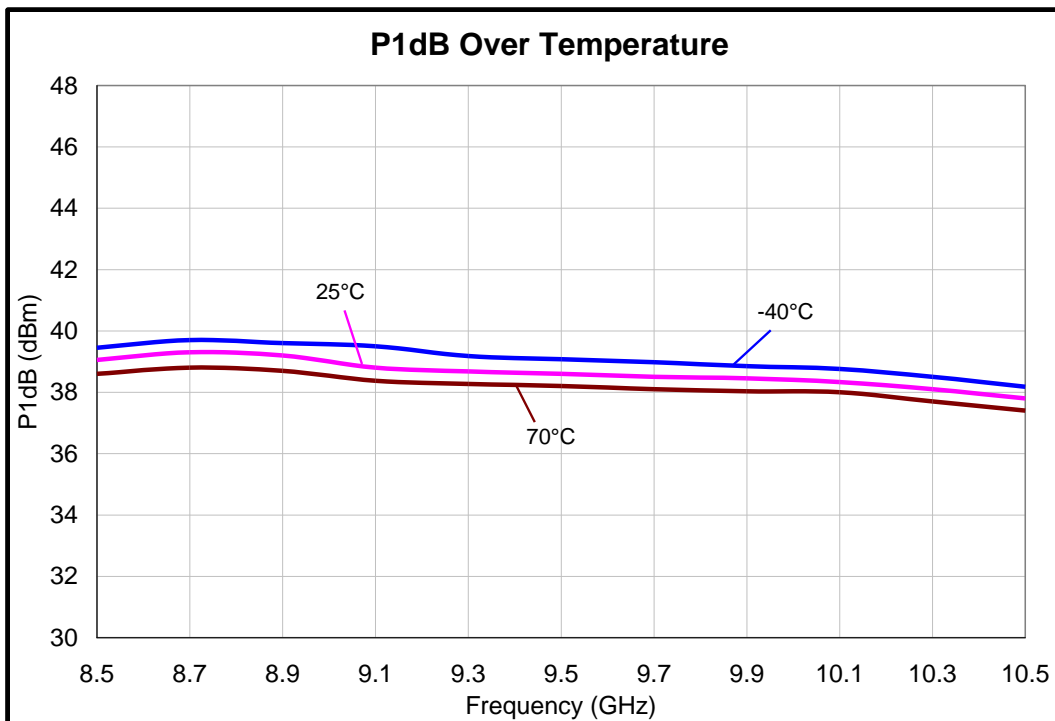
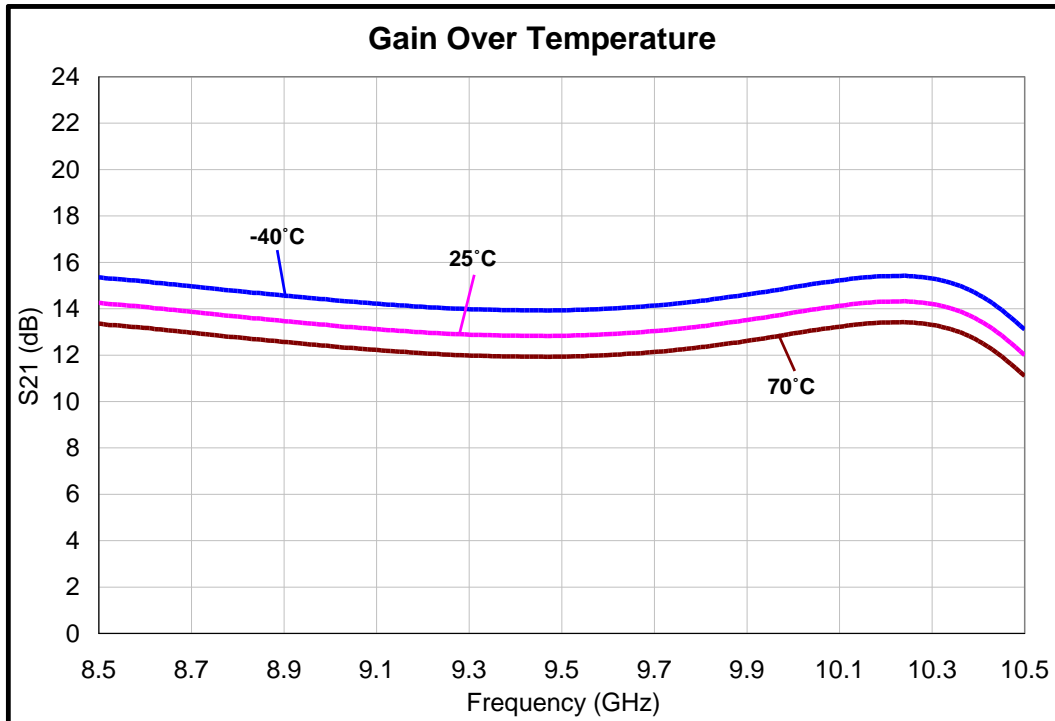
Test fixture data
 $V_{d1} = V_{d2} = 8V$, $V_{g1} = V_{g2} = -1.1V$, Total Current (I_{dq}) = 2.9A, $T_A = 25\text{ }^\circ\text{C}$, Continuous DC Mode


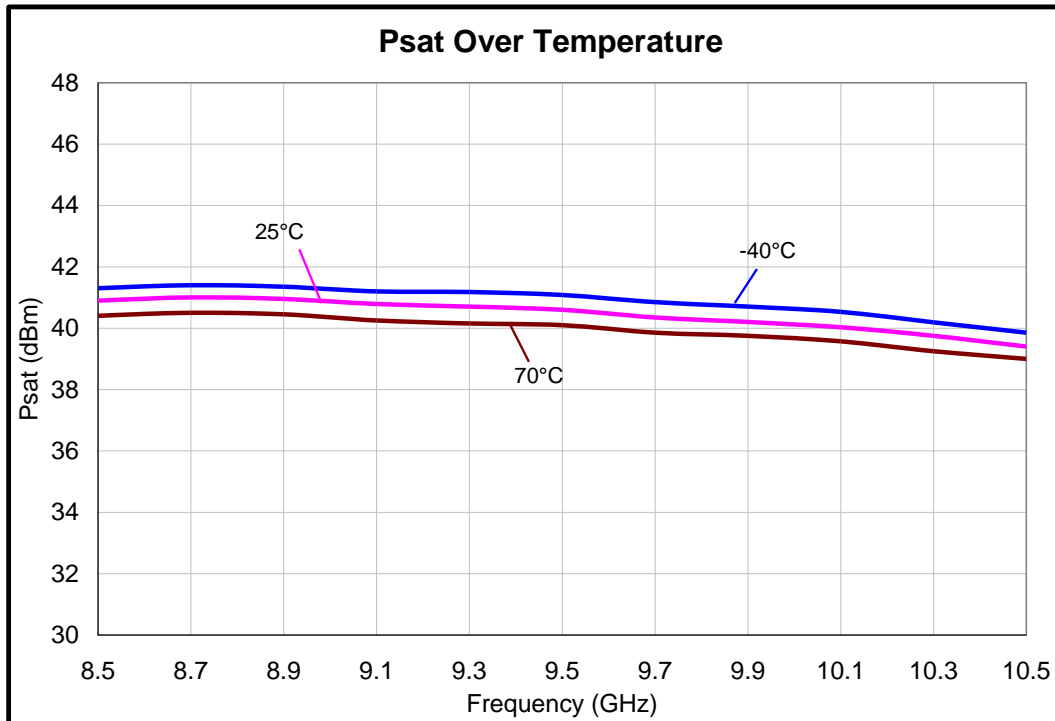
Output Power Plots (Continuous DC Mode):


$V_{d1} = V_{d2} = 8V$, $V_{g1} = V_{g2} = -1.1V$, Total Current (I_{dsat}) = 4A, Freq = 9.5GHz, $T_A = 25^\circ C$

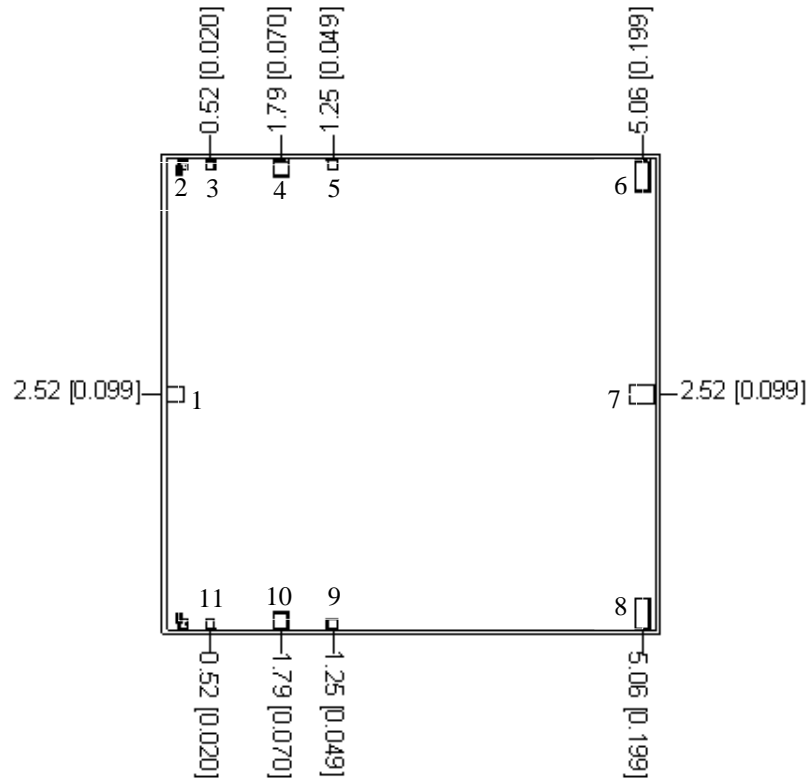


$V_{d1} = V_{d2} = 9V$, $V_{g1} = V_{g2} = -1.1V$, Total Current (I_{dsat}) = 4A, Freq = 9.5GHz, $T_A = 25^\circ C$

Temperature data:
 $V_{d1} = V_{d2} = 8V$, $V_{g1} = V_{g2} = -1.1V$, Total Current (I_{dq}) = 2.9A, $T_A = 25^\circ C$, Continuous DC Mode


Temperature data:
 $V_{d1} = V_{d2} = 8V$, $V_{g1} = V_{g2} = -1.1V$, Total Current (I_{dq}) = 2.9A, $T_A = 25\text{ }^\circ\text{C}$, Continuous DC Mode


Bond Pad Locations

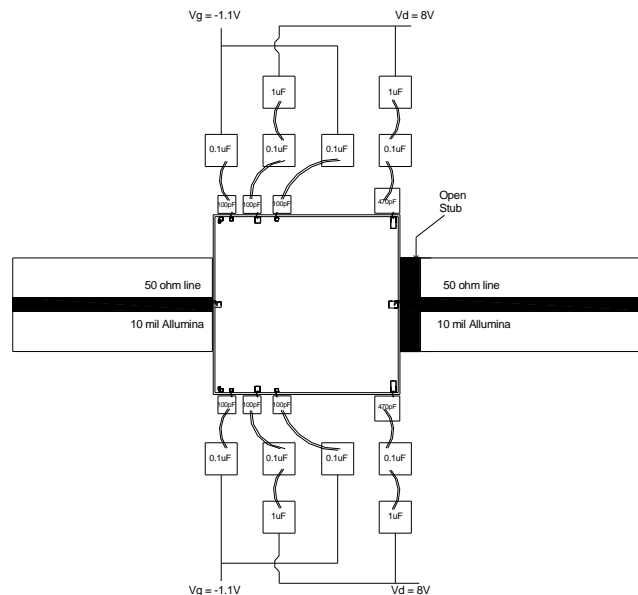


Units: millimeters (inches)

Note:

1. All RF and DC bond pads are 100 μ m x 100 μ m
2. Pad no. 1 : RF IN
3. Pad no. 3,11 : 1st stage gate voltage(V_{g1})
4. Pad no. 7 : RF Output
5. Pad no. 4,10 : 1st stage drain voltage(V_{d1})
6. Pad no. 5,9 : 2nd stage gate voltage(V_{g2})
7. Pad no. 6,8 : 2nd stage drain voltage (V_{d2})
8. All the dimensions shown above are measured taking bottom left corner as reference.

Recommended Assembly Diagram



Note :

1. Open stub of 4mm length, 1mm width and 0.05mm thickness to be placed at output immediate to the chip as shown above, so as to improve output power match.
2. Two 1 mil (0.0254mm) bond wires of minimum length should be used for RF input and output.
3. Two 1 mil (0.0254mm) bond wires of minimum length should be used from chip bond pad to 100pF capacitor.
4. Input and output 50 ohm lines are on 5 mil RT Duroid substrate.
5. 100pF (Single Layer), 0.1uF and 1uF bypass capacitors are used as shown above.
6. The RF input & output ports are DC decoupled on-chip.
7. Proper heat sink like Copper tungsten or copper molybdenum to be used for better reliability of chip.

Die attach: For Epoxy attachment, use of a two-component conductive epoxy is recommended. An epoxy fillet should be visible around the total die periphery. If Eutectic attachment is preferred, use of fluxless AuSn (80/20) 1-2 mil thick preform solder is recommended. Use of AuGe preform should be strictly avoided.

Wire bonding: For DC pad connections use either ball or wedge bonds. For best RF performance, use of 150 - 200µm length of wedge bonds is advised. Single Ball bonds of 250-300µm though acceptable, may cause a deviation in RF performance.



GaAs MMIC devices are susceptible to Electrostatic discharge. Proper precautions should be observed during handling, assembly & testing

All information and Specifications are subject to change without prior notice